



FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**

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Sheet 1 of 1

ATTORNEY DOCKET NO.

2001U-001640

SERIAL NO.

10/760,179

APPLICANT

WILLIAM V. ALCINI, et al

FILING DATE

January 16, 2004

GROUP

2837

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	ESM	6,173,808	01/2001	Maeda et al.		
2.	ESM	US2003/0145584A1	08/2003	Ciray		

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	ESM	57076220	05/13/1982	Japan(English translation of Abstract only)			
2.	ESM	2000257418	09/18/2000	Japan(English translation of Abstract only)			

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	ESM	European Search Report dated 11 April 2005, re EP Application No. 05000646.9

Examiner: /Edgardo San Martin/

Date Considered:

05/05/2006

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Sheet 1 of 1

ATTORNEY DOCKET No.

2001U-001640

SERIAL No.

10/760179

APPLICANT

William V. Alcini

FILING DATE

January 16, 2004

GROUP

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U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	ESM	1,403,614	01/1922	Malsack		
2.		2,625,234	01/1953	Fina		
3.		3,620,330	11/1971	Hall		
4.		4,665,692	05/1987	Inaba		
5.		4,690,163	09/1987	Steinemann		
6.		4,913,260	04/1990	Fallon		
7.		5,801,343	09/1998	Suzuki et al.		
8.		5,708,237	01/1998	Maeda et al.		
9.		5,971,098	10/1999	Suzuki et al.		
10.		6,065,564	05/2000	Uegane		
11.		6,176,347	01/2001	Chae et al.		
12.	ESM	6,581,721	06/2003	Nagai et al.		

FOREIGN PATENT DOCUMENTS

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OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

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